


<b>Search Notes</b>  	<b>Application/Control No.</b>  10539400	<b>Applicant(s)/Patent Under Reexamination</b>  FUJIKAWA ET AL.
	<b>Examiner</b>  Hailey, Patricia L	<b>Art Unit</b>  1793

SEARCHED			
Class	Subclass	Date	Examiner
502	208, 210, 211, 213, 313-316	6/22/09	PLH

SEARCH NOTES		
Search Notes	Date	Examiner
Search updated from previous action (searching initiated 06/15/09); EAST search	6/22/09	PLH
Inventor search	6/22/09	PLH
Inspected 10/594,451; consulted w/Exr. McCaig ('451 assigned thereto)	6/15/09	PLH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
502	208, 210,211,213,313-316	6/22/09	PLH

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